


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564428	<b>Applicant(s)/Patent Under Reexamination</b>  ECOFF ET AL.
	<b>Examiner</b>  M. Lee	<b>Art Unit</b>  2622

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	678, 554-558, 705, 706, 725, 726, 731	9/23/08	ml

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
east	9/23/08	ml

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/M. Lee/ Primary Examiner.Art Unit 2622
--	--